

47 CFR PART 15B

TEST REPORT

of

e-AR Activity Sensor

Model Name: e-AR
Brand Name: e-AR
Trade Name: Sensixa
Report No.: SZ09080052E04
FCC ID: XSH-EARB1

prepared for

Sensixa Limited.

53 Cavendish Road, London SW12 0BL, UK

prepared by

Shenzhen Electronic Product Quality Testing Center

Morlab Laboratory

3/F, Electronic Testing Building, Shahe Road, Xili,
Nanshan District, Shenzhen, 518055 P. R. China

Tel: +86 755 86130398

Fax: +86 755 86130218



NOTE: This test report can be duplicated completely for the legal use with the approval of the applicant; it shall not be reproduced except in full, without the written approval of Shenzhen Electronic Product Quality Testing Center Morlab Laboratory. Any objections should be raised to us within thirty workdays since the date of issue.

TABLE OF CONTENTS

1. TEST CERTIFICATION	3
2. GENERAL INFORMATION	4
2.1 EUT Description	4
2.2 Test Standards and Results	5
2.3 Facilities and Accreditations	6
2.3.1 Facilities	6
2.3.2 Test Environment Conditions	6
2.3.3 Measurement Uncertainty	6
3. TEST CONDITIONS SETTING.....	7
3.1 Test Mode	7
3.2 Test Setup and Equipments List.....	8
3.2.1 Conducted Emission.....	8
3.2.2 Radiated Emission.....	9
4. 47 CFR PART 15B REQUIREMENTS	10
4.1 Conducted Emission	10
4.1.1 Requirement	10
4.1.2 Test Description	10
4.1.3 Test Result.....	10
4.1.3.1 Test Plots	11
4.2 Radiated Emission	12
4.2.1 Requirement	12
4.2.2 Test Description	12
4.2.3 Test Result.....	12

Change History		
Issue	Date	Reason for change
1.0	October 13, 2009	First edition
2.0	November 5, 2009	Retest the Radiated Emission and change the test plots on page 13

1. TEST CERTIFICATION

Equipment under Test: e-AR Activity Sensor

FCC ID XSH-EARB1

Trade Name: Sensixa

Model Name: e-AR

Applicant: Sensixa Limited

53 Cavendish Road, London SW12 0BL, UK

Manufacturer: Group Sense Mobile-Tech Limited

6/F., Enterprise Place, 5 Science Park West Avenue, Hong Kong
Science Park, Shatin, N.T, Hong Kong

Test Standards: 47 CFR Part 15 Subpart B(10-1-05 Edition)

Test Date(s): Sep 10, 2009 - Nov 5, 2009

Test Result: PASS

* We Hereby Certify That:

The equipment under test was tested by Shenzhen Electronic Product Quality Testing Center Morlab Laboratory. The test data, data evaluation, test procedures and equipment configurations shown in this report were made in accordance with the requirement of related FCC rules.

The test results of this report only apply for the tested sample equipment identified above. The test report shall be invalid without all the signatures of the test engineer, the reviewer and the approver.

Tested by:

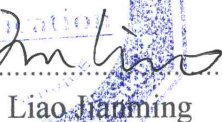


Cao Shaodong

Dated:

2009.11.5

Reviewed by:

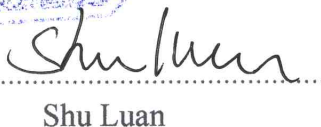


Liao Jianming

Dated:

2009.11.5

Approved by:



Shu Luan

Dated:

2009.11.5

2. GENERAL INFORMATION

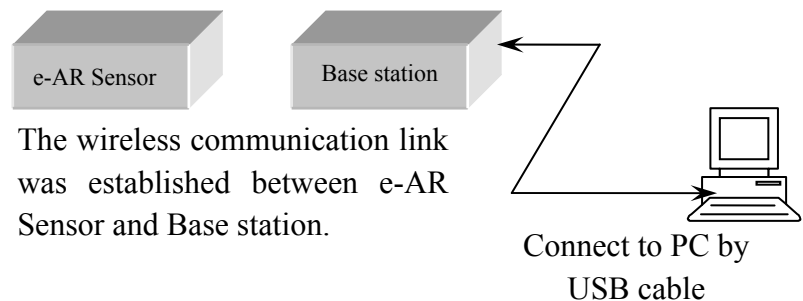
2.1 EUT Description

EUT Type.....: e-AR Activity Sensor
 Model Name: e-AR
 Serial No.....: (n.a.)

Hardware Version: e-AR Sensor rev3.3a-v8/ e-AR Base Station rev3.3a-v8
 Software Version.....: e-AR Activity Sensor v1.2
 Power Supply.....: (see Ancillary Equipments 1)
 Ancillary Equipments 1: Battery of e-AR Sensor

Model Name: LP301125-PCB-LD
 Brand Name: EEMB
 Capacitance: 47mAh
 Rated Voltage: 3.7V
 Charge Limit: 4.2V
 Manufacturer: EEMB Co., Ltd

Test Sample Sketch.....: The 2.4GHz e-AR Activity Sensor can not work without the Base station together with the PC



During the tests, a special program, supplied by applicant, installed in a Personal Computer (PC) is employed to control the Test Sample to work appropriately through their serial ports.

Note 1: The EUT is 2.4GHz e-AR Activity Sensor; it is composed of e-AR Sensor and Base station.

Note 2: The EUT operates at 2.4GHz ISM band. The Base station is powered by USB of PC; the e-AR Sensor is supply by battery.

Note 3: For a more detailed description, please refer to Specification or User's Manual supplied by the applicant and/or manufacturer.

2.2 Test Standards and Results

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

No.	Identity	Document Title
1	47 CFR Part 15 (10-1-05 Edition)	Radio Frequency Devices

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Result	Test date
1	15.107	Conducted Emission	PASS	2009-9-27
2	15.109	Radiated Emission	PASS	2009-9-27

NOTE:

The tests were performed according to the method of measurements prescribed in ANSI C63.4 2003.

2.3 Facilities and Accreditations

2.3.1 Facilities

Shenzhen Electronic Product Quality Testing Center Morlab Laboratory is a testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L1659.

All measurement facilities used to collect the measurement data are located at Electronic Testing Building, Shahe Road, Xili, Nanshan District, Shenzhen 518055 CHINA. The test site is constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22; the FCC registration number is 741109.

2.3.2 Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	20 – 25
Relative Humidity (%):	40 - 60
Atmospheric Pressure (kPa):	101

2.3.3 Measurement Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Uncertainty of Conducted Emission:	±1.8dB
Uncertainty of Radiated Emission:	±3.1dB

3. TEST CONDITIONS SETTING

3.1 Test Mode

The EUT is a 2.4GHz e-AR Activity Sensor, it is composed of e-AR Sensor and Base station. The Base station is powered by USB of PC. The 2.4GHz e-AR Activity Sensor can not work without the Base station together with the PC.

(1) The first test mode (2.4GHz Data transmission)

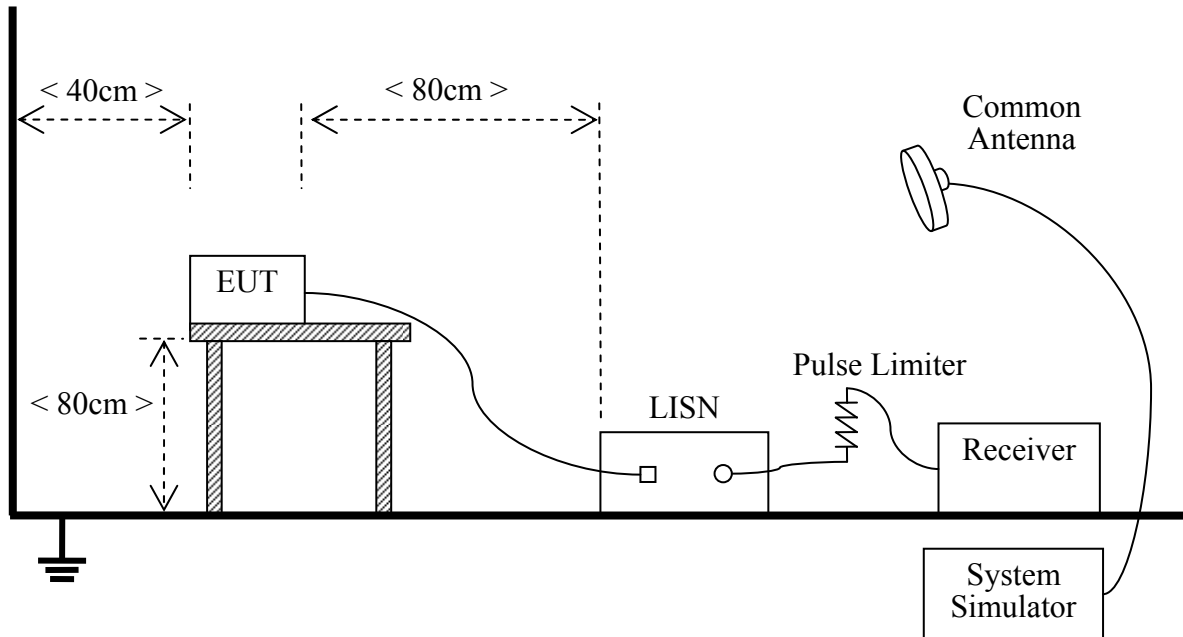
The EUT configuration of the emission tests is e-AR Sensor + Base station + PC.

During the tests in this report, The Base station which controlled by a PC operates at 2.4GHz ISM band and a communication link was established between the e-AR Sensor and Base station. The e-AR Sensor operated at 2.4GHz ISM band. The Data transmission between the e-AR Sensor and Base station is continually working.

3.2 Test Setup and Equipments List

3.2.1 Conducted Emission

A. Test Setup:



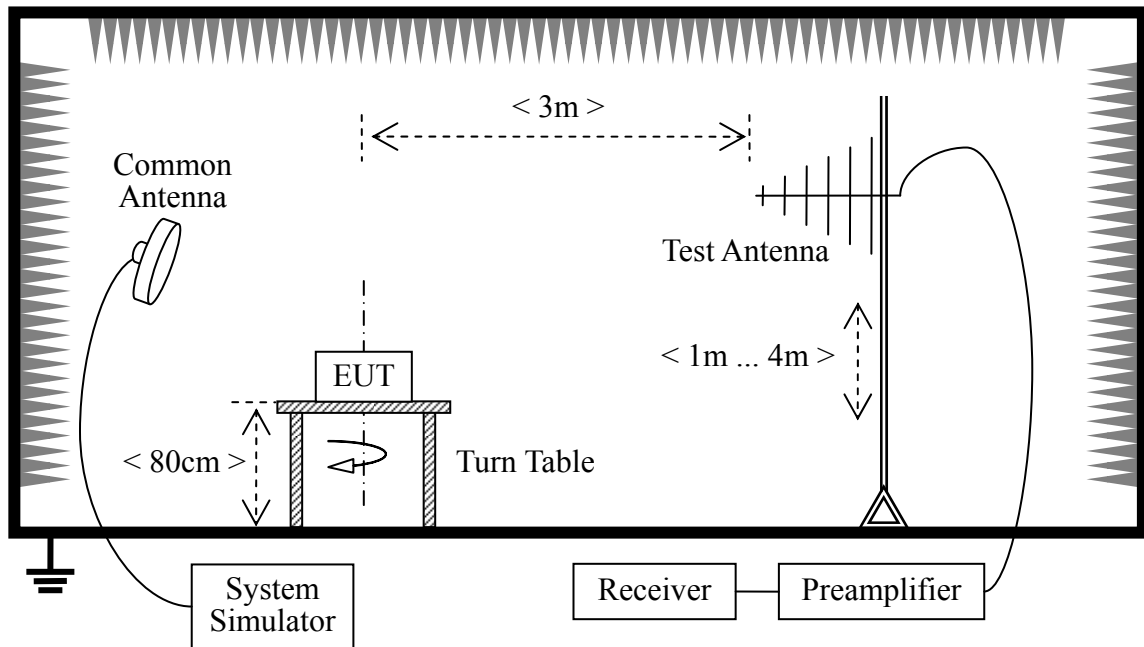
The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides $50\Omega/50\mu\text{H}$ of coupling impedance for the measuring instrument. The Common Antenna is used for the call between the EUT and the System Simulator (SS). A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

B. Equipments List:

Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due
Receiver	Agilent	E7405A	US44210471	2009.09	1year
LISN	Schwarzbeck	NSLK 8127	812744	2009.09	1year
Pulse Limiter (20dB)	Schwarzbeck	VTSD 9561-D	9391	(n.a.)	(n.a.)
System Simulator	Agilent	E5515C	GB43130131	2009.09	1year
Personal Computer	IBM	IBM_T20	(n.a.)	(n.a.)	(n.a.)
Bluetooth-Headset	Nokia	HS-36W	(n.a.)	(n.a.)	(n.a.)
T-Flash Card	SanDisk	256MB	(n.a.)	(n.a.)	(n.a.)

3.2.2 Radiated Emission

C. Test Setup:



The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a variable-height antenna master tower. The Common Antenna is used for the call between the EUT and the System Simulator (SS).

D. Equipments List:

Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due
Receiver	Agilent	E7405A	US44210471	2009.09	1year
Semi-Anechoic Chamber	Albatross	9m*6m*6m	(n.a.)	2009.09	2year
Test Antenna - Bi-Log	Schwarzbeck	VULB 9163	9163-274	2009.09	1year
Test Antenna - Horn	Schwarzbeck	BBHA 9120C	9120C-384	2009.09	1year
System Simulator	Agilent	E5515C	GB43130131	2009.09	1year
Personal Computer	IBM	IBM_T20	(n.a.)	(n.a.)	(n.a.)
Bluetooth-Headset	Nokia	HS-36W	(n.a.)	(n.a.)	(n.a.)
T-Flash Card	SanDisk	256MB	(n.a.)	(n.a.)	(n.a.)

4. 47 CFR PART 15B REQUIREMENTS

4.1 Conducted Emission

4.1.1 Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a 50 μ H/50 Ω line impedance stabilization network (LISN).

Frequency range (MHz)	Conducted Limit (dB μ V)	
	Quai-peak	Average
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

NOTE:

- a) The limit subjects to the Class B digital device.
- b) The lower limit shall apply at the band edges.
- c) The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50MHz.

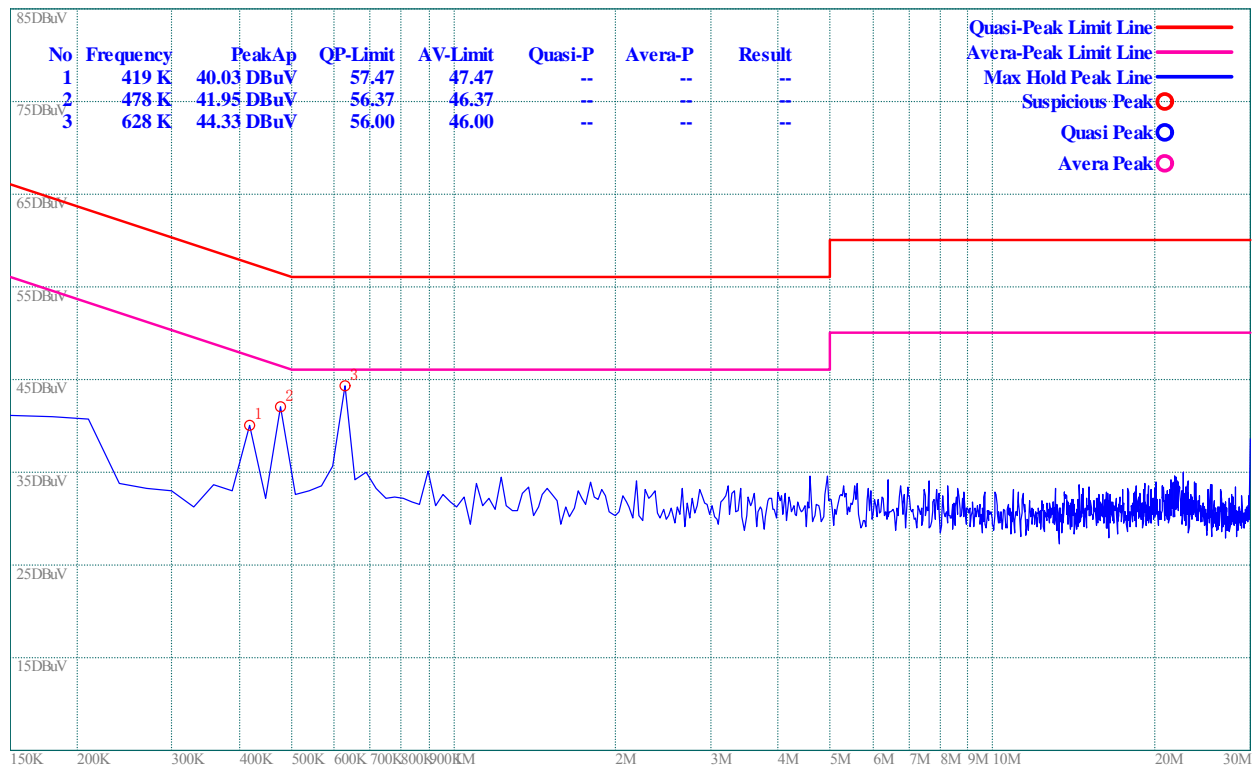
4.1.2 Test Description

See section 3.2.1 of this report.

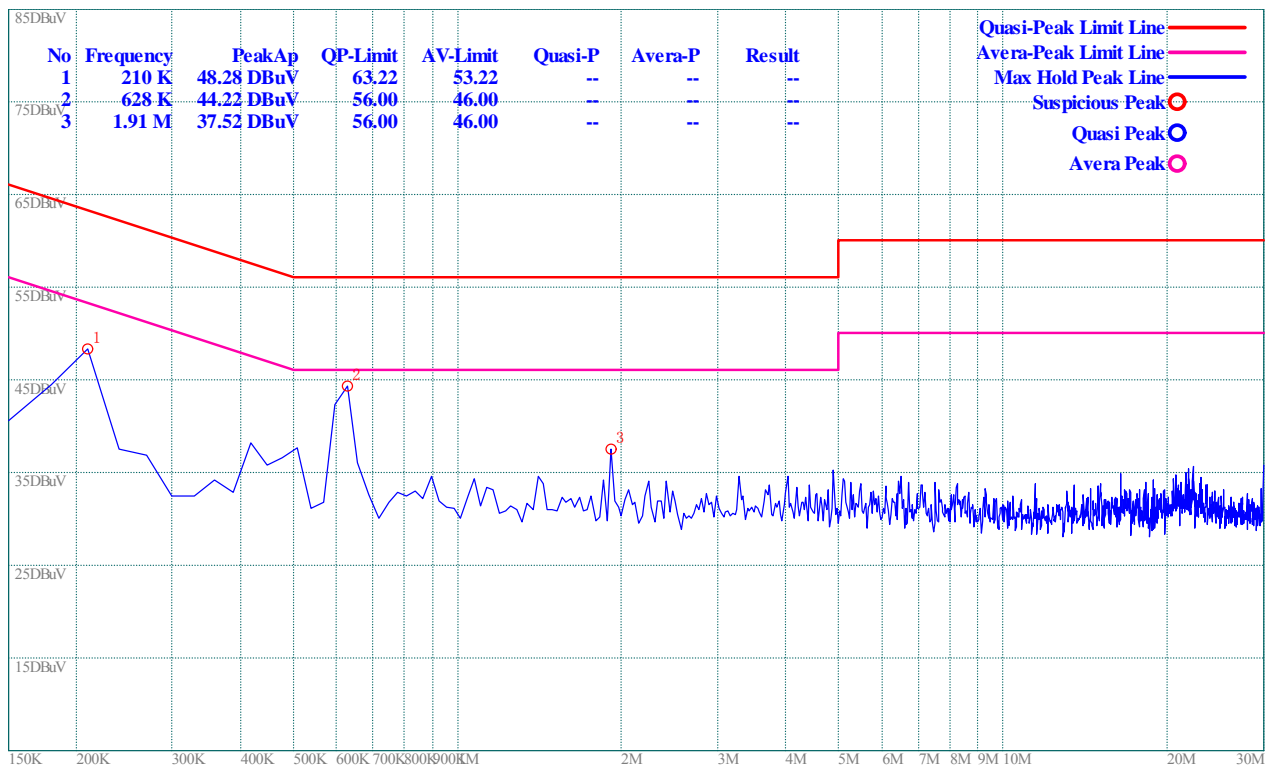
4.1.3 Test Result

The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

4.1.3.1 Test Plots



(Plot A: L Phase)



(Plot B: N Phase)

4.2 Radiated Emission

4.2.1 Requirement

According to FCC section 15.109, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency range (MHz)	Field Strength	
	$\mu\text{V/m}$	$\text{dB}\mu\text{V/m}$
30 - 88	100	40
88 - 216	150	43.5
216 - 960	200	46
Above 960	500	54

NOTE:

- a) Field Strength ($\text{dB}\mu\text{V/m}$) = $20 \cdot \log[\text{Field Strength } (\mu\text{V/m})]$.
- b) In the emission tables above, the tighter limit applies at the band edges.

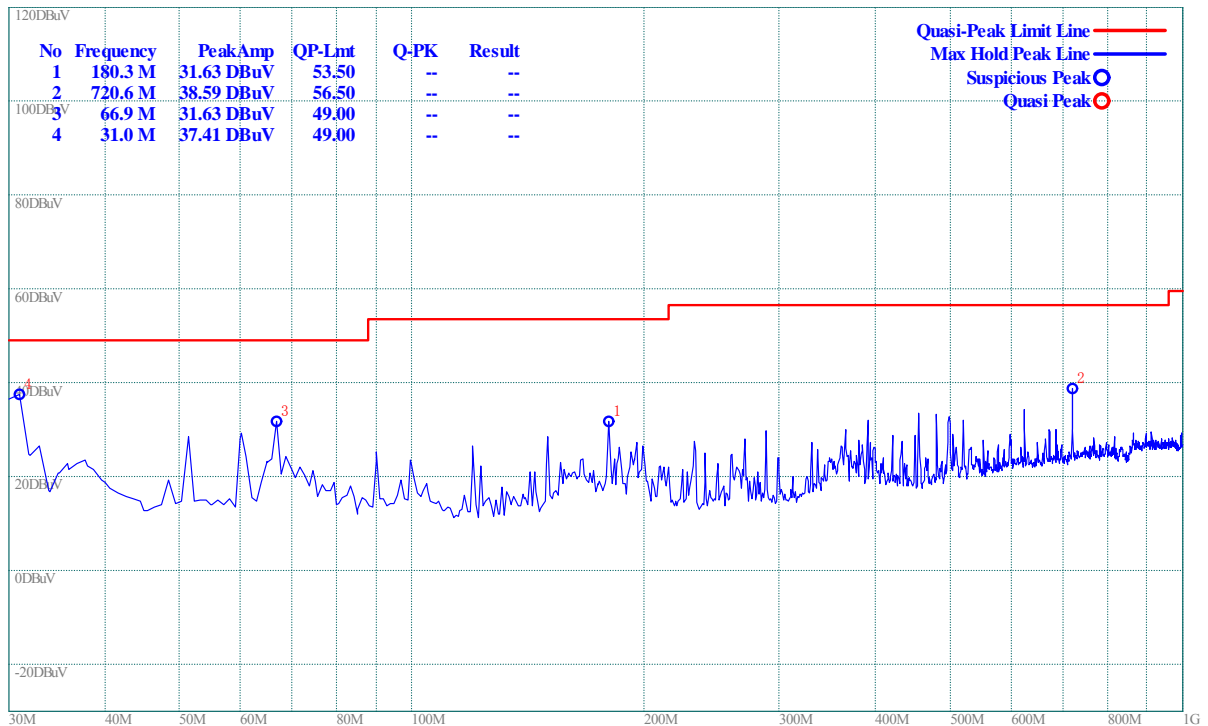
4.2.2 Test Description

See section 3.2.2 of this report.

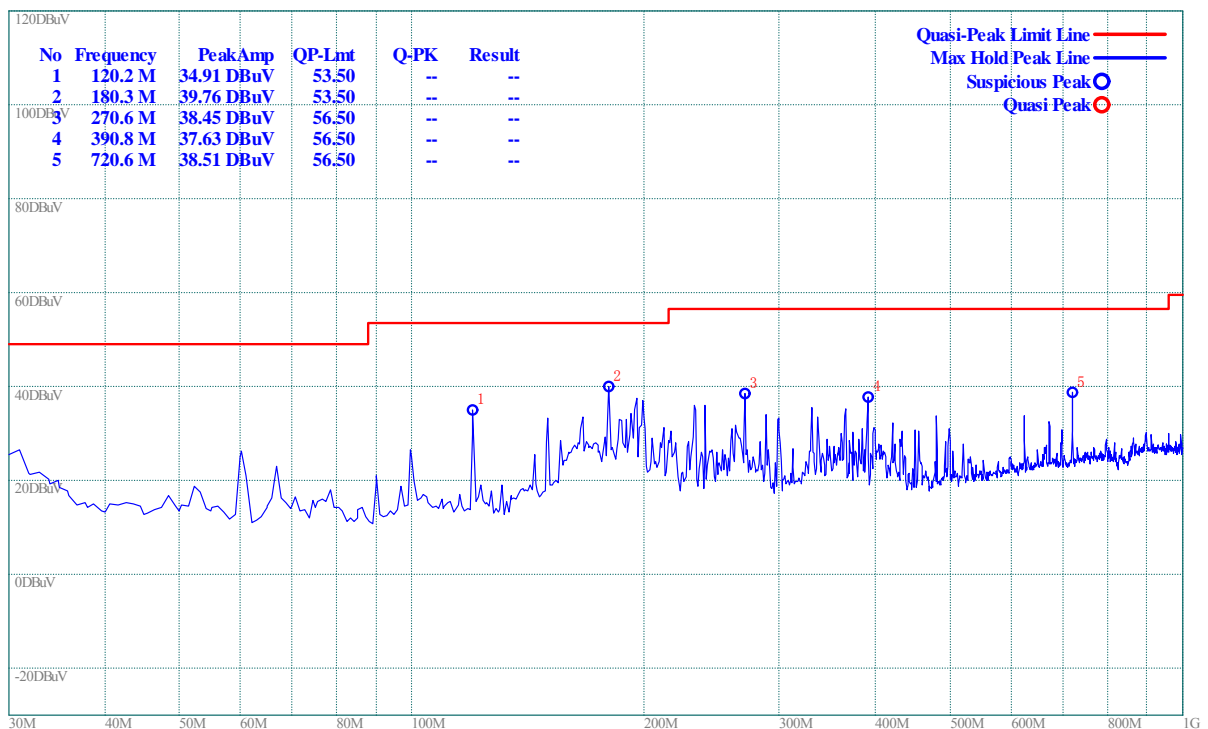
4.2.3 Test Result

The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

4.2.3.1 Test Plots



(Plot A: Test Antenna Vertical)



(Plot B: Test Antenna Horizontal)

** END OF REPORT **